

**Search Notes**

Application/Control No.

10/519,266

Examiner

Christopher S. Kim

Applicant(s)/Patent under  
Reexamination

FEKETE ET AL.

Art Unit

3752

**SEARCHED**

Class	Subclass	Date	Examiner
239	102.2	10/25/2007	CK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR